

QUERY CONTROL FORM		RTIS USE ONLY	
Application No. <u>09/865,197</u>	Prepared by <u>BSH</u>	Tracking Number <u>05938755</u>	
Examiner-GAU <u>Kim-2871</u>	Date <u>05-20-04</u>	Week Date <u>04-19-2004</u>	
	No. of queries <u>1</u>	<u>IFN-RU8</u>	

## JACKET

a. Serial No.	f. Foreign Priority	k. Print Claim(s)	p. PTO-1449
b. Applicant(s)	g. Disclaimer	l. Print Fig.	q. PTOL-85b
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other

## SPECIFICATION

- a. Page Missing
- b. Text Continuity
- c. Holes through Data
- d. Other Missing Text
- e. Illegible Text
- f. Duplicate Text
- g. Brief Description
- h. Sequence Listing
- i. Appendix
- j. Amendments
- k. Other

## CLAIMS

- a. Claim(s) Missing
- b. Improper Dependency
- c. Duplicate Numbers
- d. Incorrect Numbering
- e. Index Disagrees
- f. Punctuation
- g. Amendments
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## MESSAGE

PTO-1449: Please either initial or line through citations. Copy provided for reference.

Thank you

initials BSH

## RESPONSE

initials



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**PATENT AND TRADEMARK OFFICE  
INFORMATION DISCLOSURE CITATION**

(Use several sheets if necessary)

Sheet 1 of 2

ATTORNEY DOCKET NO.

9319S-000214

SERIAL NO.

09/865,197

APPLICANT

Hanakawa, et al.

FILING DATE

May 24, 2001

GROUP

2871

**U.S. PATENT DOCUMENTS**

Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.		2001/0026120	Oct/2001	Fukuyoshi, et al.		

**FOREIGN PATENT DOCUMENTS**

R 1. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation *	
						Yes	No
1.		11-282383	Oct/1999	Japan		Abstract	
2.		EP 0 733 931 A3	Aug/1997	Europe			
3.		EP 0 733 931 A2	Sep/1996	Europe			

**OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)**

Ref. Desig.	Examiner's Initials	
1.		Communication from European Patent Office regarding counterpart application
2.		Patent Abstracts of Japan for JP 2000-180848
3.		Patent Abstracts of Japan for JP 2000-019507
4.		Patent Abstracts of Japan for JP 11-224647
5.		Patent Abstracts of Japan for JP 08-262207
6.		Patent Abstracts of Japan for JP 08-146219

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